

In re the Application of

Inventors: K. WANG CHEN

Application No.: New Patent Application

Filed: July 21, 2003

For: TENON-SNAP JOINT STRUCTURE FOR GLASS PANEL
MOUNTING FRAMES

INFORMATION DISCLOSURE STATEMENT

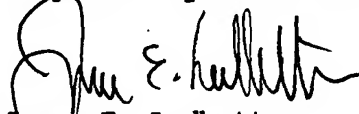
Honorable Commissioner of
Patents and Trademarks
Washington, DC 20231

Sir:

Pursuant to Rules 56 and 99, Applicants hereby call the attention of the Patent Office to the reference(s) listed on the attached Form PTO 1449.

Applicants present this art so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see Beckman Instruments, Inc. v. Chemtronics, Inc., 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir. 1970). Also see Patent Office Rules 104 and 106. Applicants respectfully request that this art be expressly considered during the prosecution of this application and made of record herein and appear among the "References Cited" on any patent to issue herefrom.

Respectfully submitted,



James E. Ledbetter
Registration No. 28,732

Date: July 21, 2003

JEL/apg

ATTORNEY DOCKET NO. L9079.03105
STEVENS, DAVIS, MILLER & MOSHER, L.L.P.
1615 L Street, NW, Suite 850
P.O. Box 34387
Washington, DC 20043-4387
Telephone: (202) 785-0100
Facsimile: (202) 408-5200

FORM PTO-1449 U.S. Department of Commerce
(Rev. 4/92) Patent and Trademark Office**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use several sheets if necessary)

ATTY. DOCKET NO.
L9079.03105SERIAL NO.
UnassignedAPPLICANT
K. WANG CHENFILING DATE
July 21, 2003GROUP
Unassigned**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	5 1 3 3 1 6 8	07/1992	Neilly et al.			
	5 3 6 9 9 2 2	12/1994	Hansen			
	5 5 7 7 3 5 5	11/1996	Leonelli			
	5 6 4 4 8 8 1	07/1997	Neilly			
	6 5 5 3 7 3 5	04/2003	Wang Chen			
	6 5 7 4 9 3 5	06/2003	Wang Chen			

FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
					YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in compliance and not considered. Include copy of this form with next communication to applicant.